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DOCUMBNY-IDENTIFIER: US 5322614 A TITLE: Device for electrolytic deposition of metals on one or both sides of

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BSPR:

According to a preferred embodiment of the invention, the corresponding anode is subdivided into several segments of the same size, where the anode segments can be held in a holder, with clear segments or insulating pieces between them.

BSPR:

The use of an anode subdivided into multiple segments in the direction of morino of the strip, according to the invention, allows several possibilities of controlling one-sided coating operation. With certain anodes, for example anodes made of iridium dioxide, it can be practical to apply a voltage which is less then that required to trigger deposition, to the individual segments of the angle segments which are voltage-free, in other words not "working," in order to prevent from passivating the ande and, at the same time, coating of the strip which is not supposed to be coated. In the individual angle needs a suitable application of charge to the ande can be controlled.

an electrical charge is applied to the anome segments in the area of the exit region, i.e. negative relative to the opposite strip segment, that reduction of the undesirable precipitation on the side of the strip which is not supposed to be coated takes place, without any significant deposition on the corresponding anode asgment occurring. consists of lead, for example, to reduce any precipitation which has formed on the side not to be coated, in one-sided operation, at the end of the strip segment passing through, by deposition in the reverse direction, in that such It is also possible, with a cathode according to the invention, if its surface

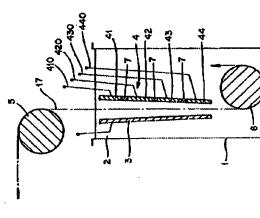
while the insoluble anode 3 is to be viewed as homogeneous over its entire length, the other insoluble anode 4 is subdivided in the direction of motion of the strip, with parallel subdividing lines. These and a subdividing lines. These and a subdividing preferably have the same size, are designated with the numbers 41, 42, 43 and 44. These segments are insulated from one another, for example by the interstices between them, as shown. The ansite esquents are held in a holder designated with the number 7. However, the electrical insulation can also be brought about by insulating segments placed between them, for example plastic segments. An electrical charge can be applied to each anode segment, by separate connections 410, 420, 430, 440. With corresponding control processes, preferably regulated and monitored, different voltages or porentials can be explied to these segments, which serve to carry out one-sided coating of a strip via the anode 3.

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 $oldsymbol{\eta}$ In a process for the electrolytic deposition of metal on one side of a strip, preferably a steel strip which forms the cathode, the section (7) of the strip to be coated is guided through a gap between two parallel anodes (3,4) which are insoluble in the electrolyte (6). A voltage can be applied to the smodes (3,4) independently of sect other. One of the two anodes is insolvided perpendicular to the direction of motion of the strip into several sections (41, 42, 43, 44) electrically insulated from each other. Voltages are selectively and independently upplied to the anode sections to prevent the side of the strip facing the anode sections from being permanently 5,322,614 Jun. 21, 1994 coated and to prevent passivation of the anode sections POREIGN PATENT DOCUMENTS 3017079 11/1981 Fed. Rep. of Occurany . 63-22908 2/1989 Jepan . 1-17190 3/1989 Jepan . Espenham et al. Prinary Examiner—John Niebling Arctum Examiner—William T. Lender Airorney, Agent, or Firm—Collard & Roc 1 Cledin, 1 Drawing Sheet Ven Resite et el. Promus et el. ABSTRACT Date of Patent: Patent Number 3,910,725 4/1975 V 3,970,337 7/1976 F 4,340,831 12/1980 S 4,347,115 8/1922 E 4,597,837 7/1986 C 2 Hans J. May, Ulmenweg 17, D-5860 Iserlohn; Roland Schmetter, Schwarter Styr. 138, D-5800 Hagen, both of Fed. Rep. of Germany Jun. 21, 1989 [DE] Fed. Rep. of Germany 3991507 302/206 ... DEVICE FOR ELECTROLYTIC DEPOSITION OF METALS ON ONE OR BOTH SIDES OF STRIPS 5 Foreign Application Priority Date U.S. PATENT DOCUMENTS PCT/DE90/00035 onned States Patent Jan. 20, 1990 WO90/08209 PCT Pub. Date: Jul. 26, 1998 Aug. 6, 1991 Aug. 6, 1991 References Offed 3,522,166 7/1970 Jones PCT Pub. No.: [58] Fleid of Search \$ 102(e) Date: 5 371 Date PCT Filed Inventors: Appl. No.: PC No. LS Q May et al. Ī E 87 8



	U.S. Patent May 9, 1989 Sheet 1 of 2 4,8.		
[ib [id tim]oot Yiram list	16 US 5156730 A 5 C C C C C C C C C C C C C C C C C C	for electroplating for electroplating by a plurality of it and it	# Fig. 4 is an explosed perspective view of anotes recommended of an anode array # Phorm in Fig. 3. # Properties of an anode array 20. # The electroplating apparatus 10 includes a pair of anodes, each of which is in the form of an anode array 20, shown in Figs. 2, 3 and 4. Each anode array 20 includes a center anode segment 2 and a plurality of generally U-shaped incide assuming an anomal and 34. Each of the U-shaped anote anomal

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the invention is directed to an at least substantially

broad aspect,

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used for the same element in each of the Pigures. Referring to PIG. 14, a prior art segmented plate ande is shown generally at 1. The ande as shown is made up of five plate angle segments. 2. Por purposes of simplicity of illustration, electrical supply means, ande support means and the like are not shown. In conjunction with a moving cathode, such cathode would be in movement across the faces of the armos asserting in the direction represented in the reference to the drawings, the same identifying number has generally been Also, as shown most particularly in the figures, it is contemplated that the Pigure by the arrow A.

about 70.degree. Advantageously, these edges will be at an angle to the direction of the path of travel of the cathode of from about 30.degree. to about 70.degree. Preferably, for most economical plate deposits such an angle will be from about 40.degree. to about 60.degree. The plate angle angle will be from about 40.degree. to about 60.degree. The plate angle angle obtained in a manner transverse to the path of travel of the moving cathode, as depicted by the center vertical line in PIG. 2, or may be positioned along the cathode travel path, in the manner as shown in PIG. 1A. cut edge will typically be at an acute angle to the path of travel of the strip. In the figures, these angles shown vary from about 40 degree. to metal strip. In the about 70.degree..

to In an at least substantially broad faced and inflaxible anode structure contening fixed anode means having at least one face adapted for use in the electrodepositing of a costing on a moving cathode in sheet or strip form, which fixed anode means comprises another in plate form, each segment the ving additional length dismensions, said another asquarts in plate form combining together to provide a broad anode face for feating relationship with said moving sheet or strip cathode, wherein the improvement comprises:

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The anode structure of claim 1, wherein the opposing bias cut edges of said is segments are separated by a non-insulated gap of from about 0.001 inch to stode requents about 0.03 inch.

The enode structure of claim 1, wherein said bias cut edge extends through a straigh structure at an angle to the path of travel of said moving cathode of .dearee. said ancia segmants at an angle to from about 30 degree, to about 70 .

PLATE ANODE HAVING BIAS CUT EDGES

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Kind Codes

CROSS-REFERENCE TO RELATED

This application is a continuation-in-part of U.S. petent application Sec. No. 309,518, filed Feb. 10, 1989, now abandoned.

BACKGROUND OF THE INVENTION

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feeding from a coil; is run through an electrobytic coal-ing process, other at this line speed. It has been known to draign the modes for such a process wherein charse-teristics such as electrobyte flow as well as other dynamlytic deposition process is electrogalymating. For such deposition, a substitute metal, such as steel in sheet form The use of non-sacrificial anodes for the continuous electrolytic coating of large objects, e.g., metal pleting of neel colts, is well known. A representative electroics must be taken into consideration.

hes been shown which has been designed by taking into consideration not only the high power requirements for an electrogalvanting operation, but also considering control and direction of electrolyse flow pattern. In the structure of the patent, elongated ismuliar smodes are positioned by bar-dapped marrant distributions onto these positioned by bar-dapped currant distributions onto these For example in U.S. Pat. No. 4,642,173 an electrode

strip exthode and the plate anode.

Where mode place are used, and especially where 13 meal arrips of varying width are to be placed, planing meal arrips of varying width are to be before, planing Because of this, it has been proposed in U.S. Fu. No. 4.119.51 to use more, housingst shaped plattes, with complementary outer Uschaped plattes, for adjusting the ot sands to varying strip widths without the need for

anode replacement.

There is still however, the need for anode structures that can be utilized in deposition operation such as electropaiventuring, which attructures provide for ecocomy of operation, uniformity of deposition without striping recousing. There is also need for enode structures of stable ejectrical connect providing unhaberupted power supply, which supply is achieved without disrup-tion of plate snode surface unflormity. For example, eserrogalvanizing a speci coil and the colled steel is moving rapidly in front of, and close to, the anode face, it is highly desirable to maintein best uniformity for and economy in replacement or repair, including anode pinte build-up at anode junctions, coupled with case where an anode is placed in an electrolyte useful for anode to cathode specing.

SUMMARY OF THE INVENTION

attructure has now been constructed. The structure pro-whele for deshibly bettered striping or deposition builds, up in costings deposited on moving estimates. The snode structure can be served by reliable electrical Bode disrupting anode turface unifor-An improved, highly efficient and rugged structure has now been constructed. The structual contact, but without mity.

In a broad sepect, the invention is directed to an at least substantially planar shaped and inflatible anode

structure containing fixed anode means having at least one face sakeped for use in the electrodepositing of a coeffig on a moving cathode in ahear or strip form, which fixed enode mean comprises a segmented plate a need the bring plate include segments combining together to provide a broad, flat anode face for facing relationship with the moving sheet or strip cathode, the improvement comprising at least one shop esegment have fing at least one biss our edge, extending serrors the D mode segment, which edge is bias ent in relation to the 2

The plate amode can have a broad free that is generally flat or curvilinear, £8, in concentric relationship with a curvilinear cathode. direction of travel of mid outhods.

FIG. 1A is a front elevational view of a segmented BRIEF DESCRIPTION OF THE DRAWINGS

anode of the prior art.
FIG. 1 is a front elevational view of a bias cut anode of the present invention.
FIG. 2 is a front elevational view of a variant for a a

bus cut anode of the present invention. variant of a bias cur mode of the present invention.

DESCRIPTION OF THE PREFERRED EMBODIMENTS

s moving since of steel as in an electrogalvanking operation of colled steel in stip form. For convenience, the smode may often be described herein in reference to use an electrodeposition operation, and fur illustrative purposes, such an operation may often be referred to as an electrogalvanking operation. However, it is to be understood that the smode is consemplated for use the electrolytic cells utilizing other electrodeposition procell whereh a deposit, e.g., a deposit of metal such as a rinc-containing deposit, is provided on a cathode. Exemplary of such operations is the electrogalvanting of a substrate metal strip such as a steel strip. The anode can be particularly utilized in an electrodeposition operation wherein the cathode is a moving cathode, such as Connectors stracted to a current feed post.

It has also been known in electrolytic electrogalisms in the present invention can find particular in S. Pr. 30 (469,565, a metal turp in non-horizontal ordents in Action 1990). The annote Electrolytic in provided on a cathode. Exting it is thown apposite a placifie annote Electrolytic in provoced by mean of electrolytic flow between the ambreness in the annote cesses, e.g., the deposition of metals such as cadmium, nickel or tin, plus metal alloys as escapilified by nickel-rice alloys, as well as in operations other than electrodeposition such as anodizing, electrophoreris and elec-

supply means, enode support means and the like are not shown. In conjunction with a moving cathode, such cathode would be in movement across the faces of the number has generally been used for the same element in each of the Figures. Referring to FIG. 1A, a point art aggmented plate anode is shown generally at 1. The anode as shown is made up of five plate anode segments 2. For purposes of simplicity of illustration, electrical enode segments in the direction represented in the Fig-In reference to the drawings, the same identifying

60 ure by the arrow A.
Referring then to FIG. 1, there is shown a bias cut
plate smode 3 of the present invention. This plus smode
3, which would otherwise be generally rectingular to trical power supply, all not shown. A second plate an-ode, also not shown, will have a bias cut edge for poxicurrent is supplied to the anode 3 by current distribu-tors, which may connect through bustwork to an elecshape, does, however, have a bias cut edge 4. Bisotnical

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espect of the present invention is concerned with an electroplating beth of an electroplating composition the receptacle to contect the bath. apparatus that includes a housing which TITLE: Electrode array and use thereof us 5156730 KWIC -----12 11 .0 9 DOCUMBNT-IDENTIFIER: US 5322614 A US 5164058 A US 5156730 A US 5098543 A US 5281325 A US 5188721 A US 5188720 A

electrically biasing each of the <u>missic segments</u> individually and for controlling the quantity of current to each of the anoid segments individually. Associated with the support means is means that are operative for electrically connecting the article to be coated to act as a cathode in an electroplating The ancde segments are independently other. A support means for supporting plurality of individual access segments. The encde segments are independentl wired and physically seperated from each other. A support means for supporting t least one article to be electroplated is provided in the receptable and in ng which contains means defining a receptacle composition. An anode array is positioned the bath. The anode array includes a bath at a location spaced from the anode array. Means are provided for trically biasing each of the anode segments individually and for

still further aspect of the present invention is concerned with a method of

electroplating an arricle. The method includes providing in a housing an anode array, the arricle to be coated speced from the anode array and means associated with the arricle for electrically connecting the arricle to act as the cathode, and an electroplating bath. The anode array includes a plurality of individual array are independently wired and physically separated from each other. Bach of the anode samenry in and an anode array includes and individually bissed and the quantity of current supplied to each of the anode array array and anode array in anode array includes and anode array and the anode current supplied to each of the anode array in and array array and anodected from the to thereby electroplate the article. snode array

Bach of the <u>appaid apparents</u> is individually wired and physically separated from the other andas segments. The andas estimates are physically separated from each other by an electrical non-conductor. Reference to FIG. 1 illustrates a schematic of a segmented anode configuration pursuant to the present invention whereby numeral 1 represents the various anode segments physically separated from each other by spacing 2 (i.e.--air acting as the non-conductor).

those electrically bias each segment and to control the quantity of the current supplied to each anode segment. Individually each of the segments can be selectively himsed by employing circuitry that contains different sized perticular multiplexor circuitry employed would be readily apparent to skilled in the art once aware of the present disclosure and need not be resistors to change the current along with a simple switching devices. estaments 1 are provided with means to individually discussed herein in any further detail. the Bach of

mesh. Ho

The particular <u>grads repressor</u> 1 shown in FIGS. 2 and 3 are platinized titanium mesh. However, each anode segment can be solid or in any mesh configuration

An electrode array containing individual electrode seg-menti braing morats to electrically bias each of the segments individually and to control the quantity of current supplied to each of the electrod segments indi-5,156,730 Micro-plate/systems, the drilling machines, PCFAB, Oct. 20, 1992 Primory Exeminer—T. M. Tutarleito Augusy, Agent or Firm—Pollock, Vande Sande & FOREIGN PATENT DOCUMENTS OTHER PUBLICATIONS 5 Claims, 2 Drawing Sheets ABSTRACT Patent Number: 228499 8/1989 Japes . 418299 8/1974 U.S.S.R. . 723185 12/1979 U.S.S.R. . 724308 12/1979 U.S.S.R. . Date of Patent: vidually; and use of the array. Feb. 1991, p. 46. [45] Pridey 5 C25D 4/02 205/118; 204/23: 204/15, 231 204/224 R 204/234 R 204/234 R 204/234 R Michael T. Freeman, John J. Konrad, both of Endicott, Narendra G. Shah, Johnson City, all of N.Y. Anillamer C. Bhett, Johnson City; ELECTRODE ARRAY AND USE THEREOF International Business Machines, Armonk, N.Y. 2 U.S. PATENT DOCUMENTS United States Patent Nath et el. References Otted Jun. 25, 1993 720,677 Im. Cl.⁵ U.S. Cl. Field of Search Appl. No.: Inventors: Assignee: Bhatt et al, Filed 222 **2** Ī Ē EE

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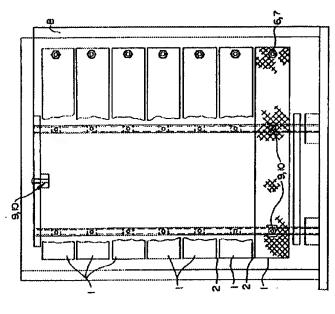
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f [oth Yrdew Heb Document ID 0 US 5089093 A	199 US 4915796 A 4D US 4871433 A 41 US 4865701 A 22 US 49183520 A 62 US 4918353 A 14 US 4670110 A	DOCUMENT-IDENTIFER: Un TITLE: Apperatus and mer computer memory hard display and the second and	Ø

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TITLE: Anode superstructure of a fused sait electrolytic cell and pot room fitted out with same OCUMENT-IDENTIFIER: US 4436607

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In the present example the level of the ancdas is adjusted pairwise; each pair of ancde rods 32 is releasably attached to an ancde beam 34. These beams 39 are be displaced in the vertical direction by means of a jacking system 36 comprising essentially a step-down genting facility 38 which operates on a spindle, not visible here, in a spindle housing 40.

204/247

CCXR: 204/279

3 United States Patent

Fischer

ANGDE SUPERSTRUCTURE OF A FUSED SALT ELECTROLYTIC CELL AND POT ROOM FITTED OUT WITH SAME

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Swize Aluminium Led., Chippis, Switzerland

Antignee

Inventor: Werner E. Fincher, Verthöne, Switzerland

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200767 E (200762 4,043,892

4,436,607 Mar. 13, 1984

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Primary Examiner—Donald R. Valentine Attorney. Agent or Firm—Bookman and LaPointe ABSTRACT

conductor sections which are ipsuced epear and have the function of feeding electric carries to the smodes we anode rook. An electrically insultated frosthridge positioned over the cell between the smode comdustors sections makes it possible to whith show the seel. A broasing with slight positive pressure created by the supply of fresh air to it, is preferably provided over this face. bridge. Treasverse cells are afranged saymmetrically in a por from. An afraight diodeable will-way in, grag-way is provided on the inside or ocated or fine form wall of the pot room. Extensions to the cell browing lead of operoprise openings in the king wall of the pot room or to the longitudinal wall of a gangway in the interior of the pot room. The fresh air is passed through the gang-way and emerges from the open and of the call bouning. Conventional fused salt reduction cells feature anod . 204/243 R-247, 204/67, 779, 286

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Fureign Application Priority Data

Jul. 1, 1982

Filed

Appl. No.: 394,115

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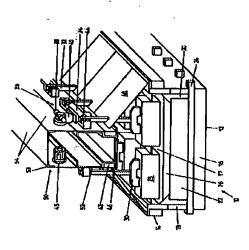
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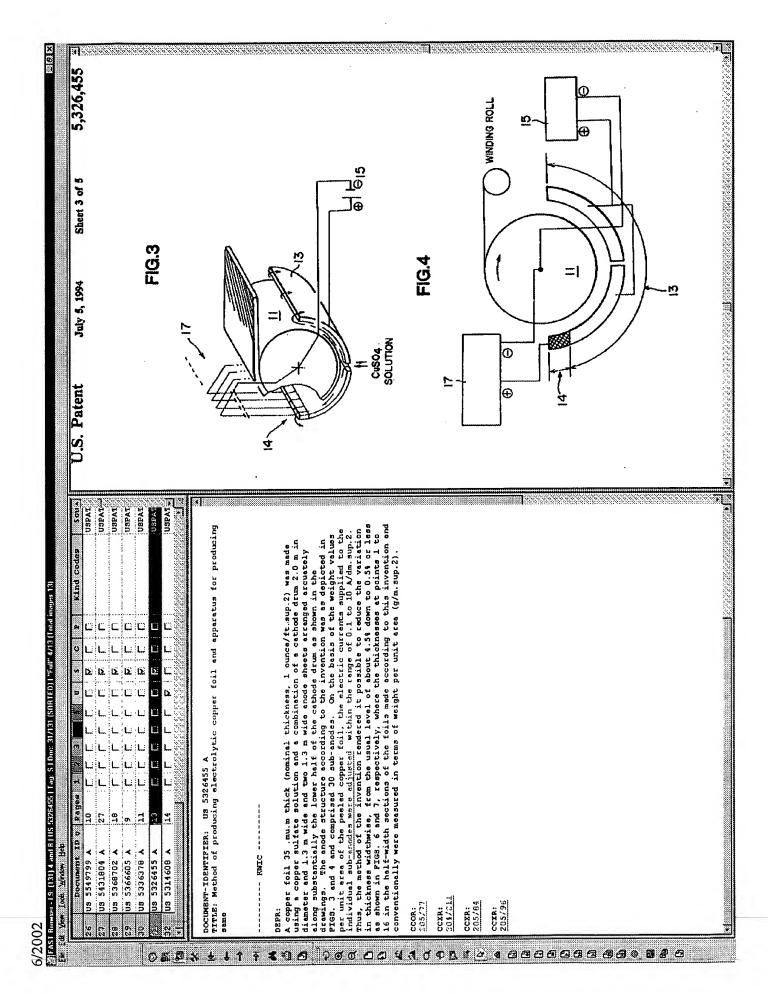
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[58] Field of Search

11 Cartos, 2 Drawing Figures





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81 10	(12) United States Patent Sakaki et al.	(10) Patent No.: US 6,332,963 B1 (45) Date of Patent: Dec. 25, 2001
	(54) CUP-TYPE PLATING APPARATUS AND METHOD FOR PLATING WAFER USING THE SAME (75) Inventors: Yasubilo Sakaki, Hiritorka; Misa	(56) References Cited U.S. PATENT DOCUMENTS 6,113,759 • 9,2000 Uzoh
XS US-PAT-NO: 6332963	_	Primary Examiner—Bruce F. Bell (74) Antorney, Agent, or Firm—Areat Fox Kinteer Plotsin & Kahn, Pl J.C.
DOCUMENT-IDENTIFIER: US 6332963 B1	(*) Notice: Subject to any disclaimer, the term of this (3)	(57) ABSTRACT ABSTRACT Acm-twe slating tent having
TITLE: Cup-type plating apparatus and method for plating wafer using the same		A support section provided on an upper and thereof for an augment section provided on an upper and thereof for holding a water, a solution feed section provided at the center of a bottom portion of the plating tank; an amode is
Current US Cross Reference Classification - CCIR (3):	(22) Filed: Sep. 24, 1999 (51) Int. Cl.'	disposed within the plating tank; and a disphragm for separating the anode from the wafer. The disphragm is stanced upward from the solution feed section toward the periphery of the plating tank. A gas release port is provided in the plating tank a recel a position as to release bubbles collected under an upper end portion of the disphragm. 3 Claims, 1 Drawing Shoet

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USPAT * USPATE USBAND | USPAT USPAT Electroplating apparatus with segmented anode array ㅁ ш ב ╚ **Σ Σ** Þ D D D Current US Cross Reference Classification - CCIR (1): D 口 ב П **See image for Certificate of Correction** Ľ ш D ш US 6497801 B1 ш ב و و و و 6497801 18 20 20 7 8 1 Document 10.00 us 6527925 B1 DOCUMENT-IDENTIFIER: US 6516233 B1 us 6508920 B1 US 6497801 B1 us 6514391 B2 us 6508926 B1 us 6503376 B2 de Merry Moots W US-PAT-NO: TITLE: **8 2 8 2 8 8** \odot J. P 390 ß T &

US 6,497,801 B1

Stranged in concentric relationship with each other. As is known in the art, the anode segments may be consumable, whereby netal ions of the anode segments are transported by the electrophising solution to the electrically conductive surface of the associated workpiece, which functions as a In this illustrated embodiment, the segmented anode array 20 includes four (4) anode segments, respectively designated 30, 32, 34 and 36. The amode segments are of relatively decreasing diameters, with the segments thus fitting one-within-the-other.

It is preferred that the anode segments be positioned in generally coplanar relationship with each other, with the segments coaxial with each other along axis "A". In order to array 20 includes a mounting base 40 upon which each of the anode segments is mounted. The mounting base 40 includes a collar portion 42 which defines a flow passage for directing flow of electroplating solution through the mounting base. In anode segments defines an opening aligned with the axis
"A" of the reactor vessel, with the flow passage defined by the collar portion of the mounting base 40 being aligned with the opening defined by this central-most one 36 of the anode maintain the segments in this relative disposition, the anode this embodiment, the central-most one of the concentric

참 Operation of this embodiment of the present invention contemplates that plating solution is pumped through inlet conduit 18, through the flow passage defined by collar the anode array so that the solution impinges upon the surface of the workpiece W. The plating rate at the surface of the workpiece ordinarily will vary radially due to the effect of the impinging solution on the hydrodynamic boundary layer. Compensation of this radial effect can be achieved by operating the anode segments at different elec-rical potentials. Such an arrangement is diagrammatically illustrated in FIG. 16, wherein controls of the present electroplaints apparatus include suitable whing for indepen-dently operating the plurality of segments of the anode array. 20. It is contemplated that not only can the various anode segments be operating at differing electrical potentials, they may also be operated for differing periods of time to optimize the uniformity of plating on the workpiece. portion 42 of mounting base 40, and through the center of

ij dielectric (insulating) elements between adjacem ones of the anode segments. This is illustrated in phantom line in FIG. 5, wherein dielectric elements 46 are positioned between each adjacent pair of the anode segments 30, 32, 34 and 36. The geometry of the dielectric elements can be modified present invention to affect uniformity by the disposition of In addition to affecting plating uniformity by using different anode potentials, it is within the purview of

to provide the desired effect on plating. Relatively tall geometries, i.e., dielectric elements which project significantly above the associated anode segments, are believed to tend to limit interaction of adjacent ones of the anode segments, and can tend to collimate solution flow to the workpiece. In contrast, shorter or perforated geometries are believed to tend to increase anode segment interaction. While the illustrated embodiments of the present invention show the anode segments positioned in coplanar relationship with each other, and thus, in generally equidistant relationship to the workpiece W, it is believed that an increase or decrease in anode segment interaction can also be achieved positioning the ring-like anode segments at varying distances from the surface of the workpiece.

Depending upon the type of electroplating process, the segments of the anode array may be either consumable, or

non-consumable. For those applications requiring a consumable anode, the anode segments can be formed from copper, anode segments can be formed from platinum plated titasuch as phosphorized copper. In contrast, non-consu-

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in the plaining chamber by the incoming plaining solution is the flushed past the workpiece surface, and thus will not inserted with the plaining process. Venings of the workpiece surface, by its angular disposition as discussed above, may also be effected. Solution flow from the center of the another and the center of the prophery. This prevents sir from being typed at the center of the workpiece when it first contexts in the surface of the solution. shown) be employed for individually securing each of the anode segments to the associated mounting base 40. Additionally, suitable sealed wiring (not shown) is provided for individually electrically connecting each of the anode segments with associated controls of the electroplating anode segment can be independently varied and controlled. In this embodiment, it is contemplated that no perforate 15 diffuser member be employed positioned between the anode array 20 and the workpiece W. Solution flow rate and current It is contemplated that suitable mechanical fasteners (not distribution can be controlled independently of one another to optimize the plating process and promote uniformity of deposition of electroplated metal. Air bubbles introduced apparatus, whereby the electrical potential created by 2

that the anode array, including the anode segments, be non-circular. 30 array having circular anode segments is particularly suited for use with circular, disk-like wafers or like workpieces. However, it is within the purview of the present invention As will be appreciated, the use of a segmented anode

alternate embodiment of the present segmented anode array. In this embodiment, elements which generally correspond to those in the above-described embodiment are designated by the reference numerals in the one-hundred series. With reference now to FIGS. 6-9, therein is illustrated an

anode segmenis are provided in concentric relationship with each other, including segments 130, 132, 134, 136 and 138... Segmented anode areay 120 includes a plurality of ring-te anode segments. In this embodiment, five (5) of the ä

tioned in coplanar relationship with each other on the mounting base, and are positioned in coaxial relationship with the axis "A" of the associated reactor vessel. The anode array 120 includes a mounting base 140 having a plurality of divider elements 141 respectively positioned between adjacent ones of the circular anode segments. As in the previous embodiment, the anode segments are posi-tioned in coplanar relationship with each other on the **\$**

directed generally about the periphery of the array. In 55 particular, the mounting base 140 includes a plurality of circumferentially spaced depending flow-modulating pro-In distinction from the previous embodiment, anode array 120 is configured such that flow of electroplating solution is jections 143 which define flow channels between adjacent ones of the projections. Electroplating solution is introduced into the reactor vessel through an inlet conduit 116, which ğ then flows between the flow-modulating projections, and inwardly of flow-modulating projections 143. The solution defines a plurality of flow passages 119 generally upper extent thereof, beneath mounting base 14 rardly generally about the anode segments. 8

This embodiment illustrates a series of openings defined those series of holes aligned at 120° intervals about the base by mounting base 140. With particular reference to FIG. 8,

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CDOCUMENT-IDENTIFIER: US 6565729 B2 中TITE: Method for electrochemically depositing metal on a semiconductor workpiece	785 686 742
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vention provides a process f cture to a workpiece on whic d using a first deposition,	or applying a h an ultra-thin process. The first

USEATE USEATE USEATE USEATE USEATE USEATE	• e	t to out to the control of the contr	nnto Lon tth
	6565729 US 6565729 B2 Method for electrochemically depositing metal semiconductor workpiece	Brief Summary Text - BSTX (19): One embodiment of the invention provides a process for applying a metallization interconnect structure to a workpiece on which an ultra-thin metal seed layer has been formed using a first deposition process. The first deposition process. The first deposition process. The first seed layer has been formed using a first deposition process. The first render it generally metal seed layer having physical characteristics that render it generally metals leed to bulk the ultra-thin metal seed layer. The process entails repairing the ultra-thin metal seed layer within a principal fluid chamber of a reactor to provide an enhansed layer using a second deposition process. The second deposition process which is different from the first deposition process, entails supplying electroplating power to a plurality of concentrack anodes disposed at different process onto the principal fluid flow chamber relative to the workpiece. After seed layer repair, additional metal is deposited in an electrolytic but plainty process onto the enhanced seed layer, under conditions in which the plainty in the process of the electrolytic deposition rate of the electrolytic deposition process is substantially greathan the deposition rate of the process used to repair the metal seed layer. Brief Summary Text - BSTX (21): Another embodiment of the invention provides a process for applying a metallization interconnect structure to a workpiece on which an ultra-thin metal seed layer has been formed using a first deposition process. The first	deposition process anchors the ultra-thin metal seed layer to an undarlying layer, the ultra-thin metal seed layer having physical characteristics that render it generally unsuitable for bulk electrolytic deposition of a metal ont the metal seed layer. The process entails subjecting the workpiece to an electrochemical deposition process entails subjecting the workpiece to an process, in an alkaline electroplating bath. The alkaline electroplating bath includes metal ions complexed with a complexing egent such that additional metal is deposited on the ultra-thin copper seed layer. This results in an enhanced seed layer. The second deposition process is carried out by supplying electroplating power to a plucality of concentric anodes disposed at different positions, relative to the workpiece, within a principal fluid flow chamber of a reactor. Thereafter, additional metal is depositied on the enhanced seed layer using an electrolytic bulk deposition process under conditions in which the deposition rate of the electrolytic deposition process is substantially greater than the deposition rate of the metal seed layer.

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(10) Patent No.: US 6,454,926 B1 (45) Date of Patent: •Sep. 24, 2002	A 6/1967 Creutz et al. A 1/1972 Wild	A 127988 Chow et al. A 177992 Yee et al. A 177992 Emblabhan et al. A 177999 Poisius et al. A 577994 Andriaccos et al. A 17799 Pois	Princay Examiner—Donald R. Valentine Assistant Examiner—William T. Leader (14) Astrorney, Agent, or Firm—Petkins Coie ILP (57) A semiconductor workpiece holder used in electroplating systems for plaining metal layers, such as copper, onto a semiconductor workpiece. The workpiece holder includes semiconductor workpiece. The workpiece in de- electrodes which extend and are natitally submerced in a	liquid planing bath. The electrodes lave a contact face which bears against the workpitch and conducts current thereber ween. The submerable portions of the electrodes are parially covered with a dielectric layer or surface. The conductive layer or surface. The conductive surfaces is updated with a dielectric layer or surface. The conductive surface is preferrably spaced from the contact face and placed in direct contact with the plating bath to allow diversion of some of the plating current directly between the electrode and plating bath. Associated methods are also described, and plating bath. Associated methods are also described.	CONTRACTOR OF THE PROPERTY OF
(12) United States Patent Rizdorf et al.	SEMICON WORKPI WORKPI WITH SU CURREN	(73) INVENTOR: Intransis, 1 seriesy 1. Kalispett, MT (US) (73) Assignee: Semttool Inc., Kalispell, MT (US) (*) Notice: This patent issued on a continued prosecution application filed under 37 CFR 1.53(5), and is subject to the twenty year patent (term provisions of 35 U.S.C.) 1.54(a.X.).	Subject to any disclaimer, the term of this patent to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(s) by 0 days. (21) Appl. No.: 08/940,669 (22) Filed: Sep. 30, 1997 (51) Int. Cl. ²	U.S. Cl. 208/96	
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wafer 31. The gap size is in a range of 0.1 mm to 5 mm, and preferably 1 mm. The process sequence is similar to that of

invention. The embodiment of FIGS, 33A-33B is similar to that of FIGS. 32A-32B except that fresh electrolyte is input from the center of the bath through pipes 260 instead of anode jets 254 through flexible pipe 258. Wafer 31 is also immersed into the electrolyte. Similarly, a movable anode is placed very close to wafer 31 in order to focus plating current on a portion of wafer 31. The gap size is in a range of 0.1 mm to 5 mm, and preferably 1 mm. The process sequence is similar to that of FIG. 30.

FIGS. 34A-34D show four embodiments of moveble FIGS. 33A-33B show another embodiment of apparatus present for plating a conductive film in accordance with the

terafluorochylene, PVC, PVDF, or polypropylene. FIG. 348 above as node structure consisting of anode 266 and case 264. FIG techerolyte is feed through a hole at the bottom of case 264. FIG. 34C above as mode structure consisting of anode 262, electrodes 274 and 270, insulator spacer 272 and case 262, and power supplies 276, 268. Electrode 274 is connected to negative output of power supply 276, and electrode 270 is connected to cathode water 31. The function 262, therefore no film is plated on the wafer area outside of esse 262. The function of electrode 270 is to prevent electrical field leakage from electrode 274 to minimize any etching effect. The embodiment of FIG. 34D is similar to that of FIG. 34C except that the case 264 has a hole at the shows an anode structure consisting of anode 252 and case 262. Case 262 is made of insulator materials such as of electrode 274 is to trap any metal ions flowing out of case anodes in accordance with the present invention. FIG. 34A

HG. 35 shows the surface status of a wafer during plating. bottom for electrolyte to flow through.

Wafer area 280 was placed by a seed layer, area 284 is in the process of plating, and wafer area 282 has not been plated FIGS 364–36C alows an additional three embodiments of apparatus for plating a conductive film in accordance with the present invention. The embodiment of FIG. 36A is similar to that of FIGS. 30A-30B except that the number of bars is increased to three. The angle between two adjacent bars is 60°. The embodiment of FIG. 36B is similar to that of FIGS. 30A-30B except that the number of bars is increased to four. The angle between two adjacent bars is i.e. half a bar. Alternatively, the number of bars can be 5, 6, 45°. The embodiment of FIG. 36C is similar to that of FIGS. 30A-30B except that the number of bars is reduced to 0.5, 7 or more.

The embodiment of FIG. 36D is similar to that of FIGS. 30A-30B except that the shape of bar 250 is a spiral instead of a straight line. Movable anode jet 254 is movable along plating uniformity can be achieved without rotating the water. This simplifies the the spiral bar so that good wafer chuck mechanism.

FIGS. 37A and 37B show additional two embodiments of apparatus for plating a conductive film in accordance with the present invention. The embodiments of FIG. 37A and 37B are similar to that of FIGS. 30A-30B, except that the wafer is placed upside down and vertically, respectively.

8 for plating a conductive film in accordance with the present invention. The embodinent of PIGS: 384, 388 is similar to set invention. The abrodient server that all of the anodes are keeplaced by a one piece anode 8. Anode 8 is connected to FIGS. 38A-38B show another embodiment of apparatus

single power supply 11. Plating process steps using this embodiment are described as follows: 9A. Process Steps for Plating Conductive Film (or Seed 3

and if the Cartesian of the control Layer) Directly on Barrier Layer. Step 1: Turn on LMFC 21, and valves 62, 63, and 64 and

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MA Step 4: Repeat step 1 to 3 for LMFC 22 (turn on LMFC 22, walves 81, 83, 84, and power supply 11, and turn of E. 23, step 5: Repeat step 1 to 3 for LMFC 23 (turn on LMFC 23, raive 82).

G. 20 Fr. Step 5: Repeat step 4 for LMFC 23 (turn on LMFC 23, raive 83).

IMFC 21, 22, 24, valve 83).

MINGS 21, 22, 24, valve 83).

Step 6: Repeat step 4 for LMFC 24 (turn on LMFC 24, valves 81, 82, 83, and power supply 11, and turn off 13, 22, LMFC 24, 22, 23 and valves 84).

from the periphery of the water to the center of the water, the plating also can be performed from the center to the In the above seed layer plating process, instead of plating periphery, or can be performed in a randomly chosen anode 30 sequence.

9B. Process Steps for Succeeding Metal Plating on the Metal Seed Layer Plated in Process 9A.
Step 7: Turn on LMFCs 21, 22, 23 and 24 and turn off valves 81, 82, 83, 84. In principle, the flow rate of electrolyte from each LMFC is set as proportional to the wafer area.

Step 8: After all flows are stabilized, turn on power supply covered by the corresponding LMFC. 2

Step 9: Turn off power supply 11 when the film thickness

ent adjust the plating film thickness uniformity as shown in FIG.

19-At time t, only LMFCA21, 23, and 24 are mined off, and radres Bi. 85, and 64 are also turned off. Therefore, else-is 41 trolyte does not tunch the wafer except in the area thore sub-plating bath 64. As the power supply II remains turned so, and area of the area thore sub-plating bath 64. Then LMFC 22 turns off at time t, Supplating bath 64. Then LMFC 22 turns off at time t, Similarly, LMFC 24 turns on at time t, and turns off at time t, LMFCs can be turned off at different times in order to L to obtain extra plating at the wafer area above sub-plating bath 60. Turn off time of 1,2 and L can be fine tuned by reaches the set-value. \$ 8

33 invention. The embodiment of FIGS. 40A-40B is similar to that of FIGS. AA-2B except that all anotes are connected to single power gapply 11. Since the electrolyte only nouches the portion of wafer above an anode during the seed layer. measuring wafer thickness uniformity.
FIGS. 40A-40B show another embodiment of apparatus plating process, the plating current will only pass through 60 the anode and go to that portion of the varier. The plating process steps are similar to those of FIGS. 3A-3B with for plating a conductive film in accordance with the present 11 replacing power supplies 12 and 13.

for plating a conductive film in accordance with the present invention. The embodiment of FIGS. 414-41B is similar to that of FIGS. 40A-40B except that the cylindrical walls can FIGS. 41A-41B show another embodiment of apparatus move up and down to adjust the flow pattern. As shown in